

Fixed capacitors for use in electronic equipment —

**Part 22: Sectional specification: Fixed
surface mount multilayer capacitors of
ceramic dielectric, Class 2**

ICS 31.060.10

National foreword

This British Standard is the UK implementation of EN 60384-22:2004. It is identical to IEC 60384-22:2004 incorporating corrigendum September 2004. Together with BS EN 60384-21:2004 it supersedes BS EN 132100:1997 which is withdrawn. Together with BS EN 60384-21:2004, BS EN 60384-21-1:2004 and BS EN 60384-22-1:2004 it supersedes BS QC 301900:1992 and BS QC 301901:1992 which are withdrawn.

The UK participation in its preparation was entrusted to Technical Committee EPL/40X, Capacitors and resistors for electronic equipment.

A list of organizations represented on this committee can be obtained on request to its secretary.

This publication does not purport to include all the necessary provisions of a contract. Users are responsible for its correct application.

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English version

Fixed capacitors for use in electronic equipment
Part 22: Sectional specification: Fixed surface mount multilayer
capacitors of ceramic dielectric, Class 2
(IEC 60384-22:2004 + corrigendum Sep. 2004)

Condensateurs fixes utilisés dans les
équipements électroniques
Partie 22: Spécification intermédiaire:
Condensateurs multicouches fixes pour
montage en surface pour diélectriques en
céramique, classe 2
(CEI 60384-22:2004 + corrigendum Sep.
2004)

Festkondensatoren zur Verwendung in
Geräten der Elektronik
Teil 22: Rahmenspezifikation:
Oberflächenmontierbare
Vielschichtkeramik-Festkondensatoren,
Klasse 2
(IEC 60384-22:2004 + corrigendum Sep.
2004)

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CENELEC

European Committee for Electrotechnical Standardization
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Europäisches Komitee für Elektrotechnische Normung

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Foreword

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This European Standard, together with EN 60384-21:2004, supersedes EN 132100:1996.

The following dates were fixed:

- | | | |
|--|-------|------------|
| – latest date by which the EN has to be implemented
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| – latest date by which the national standards conflicting
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Annex ZA has been added by CENELEC.

Endorsement notice

The text of the International Standard IEC 60384-22:2004 + corrigendum September 2004 was approved by CENELEC as a European Standard without any modification.

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FIXED CAPACITORS FOR USE IN ELECTRONIC EQUIPMENT –**Part 22: Sectional specification:
Fixed surface mount multilayer capacitors
of ceramic dielectric, Class 2****1 General****1.1 Scope**

This sectional specification is applicable to fixed unencapsulated surface mount multilayer capacitors of ceramic dielectric, Class 2, for use in electronic equipment. These capacitors have metallized connecting pads or soldering strips and are intended to be mounted on printed boards, or directly onto substrates for hybrid circuits.

Capacitors for electromagnetic interference suppression are not included, but are covered by IEC 60384-14.

1.2 Object

The object of this standard is to prescribe preferred ratings and characteristics and to select from IEC 60384-1:1999 the appropriate quality assessment procedures, tests and measuring methods and to give general performance requirements for this type of capacitor. Test severities and requirements prescribed in detail specifications referring to this sectional specification shall be of equal or higher performance level, lower performance levels are not permitted.

1.3 Normative references

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60063:1963, *Preferred number series for resistors and capacitors*
Amendment 1 (1967)
Amendment 2 (1977)

IEC 60068-1:1988, *Environmental testing – Part 1: General and guidance*

IEC 60068-2-58:1999, *Environmental testing – Part 2-58: Tests – Test Td – Test methods for solderability, resistance to dissolution of metallization and to soldering heat of surface mounting devices (SMD)*

IEC 60384-1:1999, *Fixed capacitors for use in electronic equipment – Part 1: Generic specification*

IEC 60410:1973, *Sampling plans and procedures for inspection by attributes*

IEC QC 001005: *Register of firms, products and services approved under the IECQ system, including ISO 9000*

ISO 3:1973, *Preferred numbers – Series of preferred numbers*

1.4 Information to be given in a detail specification

Detail specifications shall be derived from the relevant blank detail specification.

Detail specifications shall not specify requirements inferior to those of the generic, sectional or blank detail specification. When more severe requirements are included, they shall be listed in 1.9 of the detail specification and indicated in the test schedules, for example by an asterisk.

NOTE The information given in 1.4.1 may for convenience, be presented in tabular form.

The following information shall be given in each detail specification and the values quoted shall preferably be selected from those given in the appropriate Clause of this sectional specification.

1.4.1 Outline drawing and dimensions

There shall be an illustration of the capacitors as an aid to easy recognition and for comparison of the capacitors with others.

Dimensions and their associated tolerances, which affect interchangeability and mounting, shall be given in the detail specification. All dimensions shall preferably be stated in millimetres, however, when the original dimensions are given in inches, the converted metric dimensions in millimetres shall be added.

Normally the numerical values shall be given for the length, width and height of the body. When necessary, for example when a number of items (sizes and capacitance/voltage ranges) are covered by a detail specification, the dimensions and their associated tolerances shall be placed in a table below the drawing.

When the configuration is other than described above, the detail specification shall state such dimensional information as will adequately describe the capacitors.

1.4.2 Mounting

The detail specification shall give guidance on methods of mounting for normal use. Mounting for test and measurement purposes (when required) shall be in accordance with 4.3 of this sectional specification.

1.4.3 Rating and characteristics

The ratings and characteristics shall be in accordance with the relevant Clauses of this specification, together with the following:

1.4.3.1 Rated capacitance range

See 2.2.4.1.

NOTE When products approved to the detail specification have different ranges, the following statement should be added: "The range of capacitance values available in each voltage range is given in IECQ 001005".

1.4.3.2 Particular characteristics

Additional characteristics may be listed, when they are considered necessary to specify adequately the component for design and application purposes.

1.4.3.3 Soldering

The detail specification shall prescribe the test methods, severities and requirements applicable for the solderability and the resistance to soldering heat tests.



1.4.4 Marking

The detail specification shall specify the content of the marking on the capacitor and on the package. Deviations from 1.6 of this sectional specification shall be specifically stated.

1.5 Terms and definitions

For the purposes of this sectional specification, the terms and definitions given in IEC 60384-1, as well as the following apply.

1.5.1

surface mount capacitor

a capacitor whose small dimensions and nature or shape of terminations make it suitable for surface mounting in hybrid circuits and on printed boards

1.5.2

fixed capacitors, ceramic dielectric, Class 2

capacitor which has a dielectric with a high permittivity and is suitable for by-pass and coupling applications or for frequency discriminating circuits where low losses and high stability of capacitance are not of major importance.

The ceramic dielectric is characterized by a non linear change of capacitance over the category temperature range (see Table 3).

1.5.3

subclass

maximum percentage change of capacitance within the category temperature range with respect to the capacitance at 20 °C.

The subclass may be expressed in code form (see Table 3)

1.5.4

category temperature range

range of ambient temperatures for which the capacitor has been designed to operate continuously; this is given by the lower and upper category temperature

1.5.5

rated temperature

maximum ambient temperature at which the rated voltage may be continuously applied

1.5.6

rated voltage (d.c.)

U_R

maximum direct voltage or peak value of pulse voltage which may be applied continuously to a capacitor at any temperature between the lower category temperature and the rated temperature

NOTE The sum of the d.c. voltage and the peak a.c. voltage or the peak to peak a.c. voltage, whichever is the greater, applied to the capacitor shall not exceed the rated voltage. The value of the peak a.c. voltage shall not exceed the value determined by the permissible reactive power.

1.5.7

category voltage

U_C

maximum voltage which may be applied continuously to a capacitor at its upper category temperature

1.6 Marking

See 2.4 of IEC 60384-1 with the following details:

1.6.1 The information given in the marking is normally selected from the following list; the relative importance of each item is indicated by its position in the list:

- a) rated capacitance;
- b) rated voltage (d.c. voltage may be indicated by the symbol (--- or —);
- c) tolerance on rated capacitance;
- d) dielectric subclass as applicable (according to 2.2.5);
- e) year and month (or week) of manufacture;
- f) manufacturer's name or trade mark;
- g) climatic category;
- h) manufacturer's type designation;
- i) reference to the detail specification.

1.6.2 These capacitors are generally not marked on the body. If some marking can be applied, they shall be clearly marked with as many as possible of the above items as is considered useful. Any duplication of information in the marking on the capacitor should be avoided.

1.6.3 Any marking shall be legible and not easily smeared or removed by rubbing with the finger.

1.6.4 The package containing the capacitor(s) shall be clearly marked with all the information listed in 1.6.1.

1.6.5 Any additional marking shall be so applied that no confusion can arise.

2 Preferred rating and characteristics

2.1 Preferred characteristics

The values given in the detail specification shall preferably be selected from the following:

2.1.1 Preferred climatic categories

The capacitors covered by this sectional specification are classified into climatic categories according to the general rules given in IEC 60068-1.

The lower and upper category temperatures and the duration of the damp heat, steady state test shall be chosen from the following:

Lower category temperature: $-55\text{ }^{\circ}\text{C}$, $-40\text{ }^{\circ}\text{C}$, $-25\text{ }^{\circ}\text{C}$, $-10\text{ }^{\circ}\text{C}$ and $+10\text{ }^{\circ}\text{C}$

Upper category temperature: $+70\text{ }^{\circ}\text{C}$, $+85\text{ }^{\circ}\text{C}$, $+100\text{ }^{\circ}\text{C}$, $+125\text{ }^{\circ}\text{C}$ and $+150\text{ }^{\circ}\text{C}$

Duration of the damp heat, steady state test: 4, 10, 21 and 56 days.

The severities for the cold and dry heat tests are the lower and upper category temperatures respectively.

NOTE The resistance to humidity resulting from the above climatic category is for the capacitors in their unmounted state. The climatic performance of the capacitors after mounting is greatly influenced by the mounting substrate, the mounting method (see 4.3) and the final coating.

2.2 Preferred values of ratings

2.2.1 Rated temperature

The rated temperature is equal to the upper category temperature for capacitors with the upper category temperature not exceeding 125 °C, unless otherwise stated in the detail specification.

2.2.2 Rated voltage (U_R)

The preferred values of the rated voltage are the values of the R5 series of ISO 3. If other values are needed they shall be chosen from the R10 series.

2.2.3 Category voltage (U_C)

The category voltage is equal to the rated voltage for capacitors with the upper category temperature not exceeding 125 °C. Any category voltages which are different from the rated voltage, for capacitors with the upper category temperature exceeding 125 °C or for high voltage capacitors with rated voltages above 500 V, shall be given by the detail specification.

The preferred values of the category voltage at 125 °C upper category temperature for high volumetric capacitors with a rated voltage of 16 V and less and a rated temperature of 85 °C are given in Table 1.

Table 1 – Preferred values of category voltages

U_R	V	2,5	4	6,3	10	16
U_C	V	1,6	2,5	4	6,3	10
NOTE The numeric values of U_C are calculated by the following: $U_C = 0,63 \times U_R$						

2.2.4 Preferred values of rated capacitance and associated tolerance values

2.2.4.1 Preferred values of rated capacitance

Rated capacitance values shall be taken from the series of IEC 60063; the E3, E6 and E12 series are preferred.

2.2.4.2 Preferred tolerances on rated capacitance

See Table 2.

Table 2 – Preferred tolerances

Preferred series	Tolerance %	Letter code
E3 and E6	−20/+80	Z
	−20/+50	S
E6	±20	M
E6 and E12	±10	K

2.2.5 Temperature characteristic of capacitance

Table 3 denotes with a cross the preferred values of the temperature characteristic with and without a d.c. voltage applied. The method of coding the subclass is also given; for example a dielectric with a percentage change of ±20 % without d.c. voltage applied over the temperature range from −55 °C to +125 °C will be defined as a dielectric of subclass 2C1.

The temperature range for which the temperature characteristic of the dielectric is defined is the same as the category temperature range.

Table 3 – Temperature characteristic of capacitance

Sub-class letter code	Maximum capacitance change within the category temperature range with respect to the capacitance at 20 °C measured with and without a d.c. voltage applied %		Category temperature range and corresponding number code					
			−55/+150 °C	−55/+125 °C	−55/+85 °C	−40/+85 °C	−25/+85 °C	+10/+85 °C
	Without d.c. voltage applied	With d.c. voltage applied ¹	0	1	2	3	4	6
2B	±10	Requirements specified in the detail specification			x	x	x	
2C	±20			x	x	x		
2D	+20/−30			x			x	
2E	+22/−56				x	x	x	x
2F	+30/−80				x	x	x	x
2R	±15		x	x	x		x	
d.c. voltage applied is either rated voltage or the voltage specified in the detail specification.								
"x" indicates preferred.								
When the upper category temperature is above 125 °C, the limits of capacitance change, both with and without d.c. voltage applied shall be given in the detail specification.								

2.2.6 Dimensions

Suggested rules for the specification and coding of dimensions are given in Annex A.

Specific dimensions shall be given in the detail specification.

3 Quality assessment procedures

3.1 Primary stage of manufacture

The primary stage of manufacture is the first common firing of the dielectric-electrode assembly.

3.2 Structurally similar components

Capacitors considered as being structurally similar are capacitors produced with similar processes and materials, through they may be of different case sizes and values.

3.3 Certified records of released lots

The information required in IEC 60384-1, 3.9 shall be made available when prescribed in the detail specification and when requested by a purchaser. After the endurance test, the parameters for which variables information is required are the capacitance change, $\tan \delta$ and the insulation resistance.

3.4 Qualification approval

The procedures for qualification approval testing are given in IEC 60384-1, 3.5.

The schedule to be used for qualification approval testing on the basis of lot-by-lot and periodic tests is given in 3.5 of this sectional specification. The procedure using a fixed sample size schedule is given in 3.4.1 and 3.4.2.

3.4.1 Qualification Approval on the basis of the fixed sample size procedures

The fixed sample size procedure is described in item b) of 3.5.3 of IEC 60384-1. The sample shall be representative of the range of capacitors for which approval is sought. This may or may not be the complete range covered by the detail specification.

For each temperature characteristic, the sample shall consist of specimens of capacitors of maximum and minimum size and for each of these sizes, the maximum capacitance value for the highest rated voltage and minimum rated voltage of the voltage ranges for which approval is sought. When there are more than four rated voltages, an intermediate voltage shall also be tested. Thus for the approval of a range, testing is required of either four or six values (capacitance/voltage combinations) for each temperature characteristic. Where the total range consists of less than four values, the number of specimens to be tested shall be that required for four values.

In case assessment level EZ is used, spare specimens are permitted as follows:

Two (for six values) or three (for four values) per value which may be used as replacements for specimens, which are non-conforming because of incidents not attributable to the manufacturer.

The numbers given in Group 0 assume that all groups are applicable. If this is not so, the numbers may be reduced accordingly.

When additional groups are introduced into the qualification approval test schedule, the number of specimens required for Group 0 shall be increased by the same number as that required for the additional groups.

Table 4 gives the number of samples to be tested in each group or subgroup together with the number of the number of permissible non-conformances for the qualification approval test.

3.4.2 Tests

The complete series of tests specified in Tables 4 and 5 are required for the approval of capacitors covered by one detail specification. The tests of each group shall be carried out in the order given.

The whole sample shall be subjected to the tests of Group 0 and then divided for the other groups.

Non-conforming specimens found during the tests of Group 0 (according to Table 4) shall not be used for the other groups.

“One non-conforming item” is counted when a capacitor has not satisfied the whole or a part of the tests of a group.

The approval is granted when the number of non-conforming items do not exceed the specified number of permissible non-conforming items for each group or subgroup and the total number of permissible non-conformances.